

Amplifier, Power, 1 W
2-18 GHz

MAAP-000080-DIE000
Rev -
Preliminary Datasheet

Features

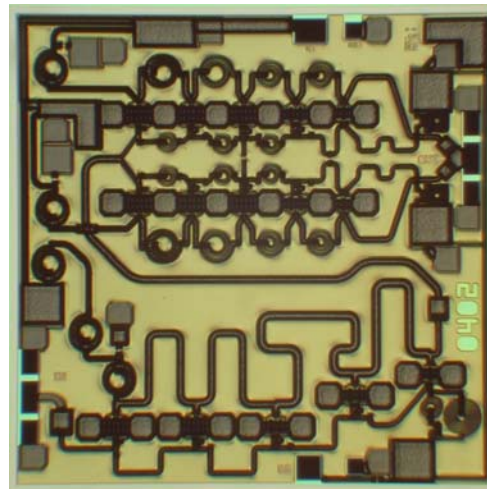
- ◆ 1 Watt Saturated Output Power Level
- ◆ Variable Drain Voltage (6-10V) Operation
- ◆ MSAG[®] Process

Description

The MAAP-000080-DIE000 is a 2-stage 1 W distributed power amplifier with on-chip bias networks. This product is fully matched to 50 ohms on both the input and output. It can be used as a power amplifier stage or as a driver stage in high power applications.

Fabricated using M/A-COM's repeatable, high performance and highly reliable GaAs Multifunction Self-Aligned Gate (MSAG[™]) Process, each device is 100% RF tested on wafer to ensure performance compliance.

M/A-COM's MSAG[™] process features robust silicon-like manufacturing processes, planar processing of ion implanted transistors, multiple implant capability enabling power, low-noise, switch and digital FETs on a single chip, and polyimide scratch protection for ease of use with automated manufacturing processes. The use of refractory metals and the absence of platinum in the gate metal formulation prevents hydrogen poisoning when employed in hermetic packaging.



Primary Applications

- ◆ Electronic Warfare
- ◆ Ultra Wideband (UWB)
- ◆ Test Instrumentation

Also Available in:

| | | SAMPLES | |
|-------------|--------------------|--------------------|-------------------------|
| Description | Plastic | Sample Board (Die) | Mechanical Sample (Die) |
| Part Number | MAAP-000080-PKG003 | MAAP-000080-SMB004 | MAAP-000080-MCH000 |

Electrical Characteristics: $T_B = 10^\circ\text{C}^1$, $Z_0 = 50\Omega$, $V_{DD} = 10\text{V}$, $I_{DQ} = 750\text{mA}^2$, $P_{in} = 22\text{ dBm}$, $R_G = 130\Omega$

| Parameter | Symbol | Typical | Units |
|------------------------|-----------|----------|-------|
| Bandwidth | f | 2.0-18.0 | GHz |
| Output Power | P_{OUT} | 30 | dBm |
| 1-dB Compression Point | P_{1dB} | 29.5 | dBm |
| Small Signal Gain | G | 11.5 | dB |
| Power Added Efficiency | PAE | 11 | % |
| Input VSWR | VSWR | 1.5:1 | |
| Output VSWR | VSWR | 1.8:1 | |
| Gate Current | I_{GG} | 5 | mA |
| Drain Current | I_{DD} | 800 | mA |

1. T_B = MMIC Base Temperature
2. Adjust V_{GG} between -2.6 and -1.2V to achieve specified I_{dq} .

Maximum Ratings³

| Parameter | Symbol | Absolute Maximum | Units |
|---------------------------------------|------------|------------------|-------|
| Input Power | P_{IN} | 27.0 | dBm |
| Drain Supply Voltage | V_{DD} | +12.0 | V |
| Gate Supply Voltage | V_{GG} | -3.0 | V |
| Quiescent Drain Current (No RF) | I_{DQ} | 0.78 | A |
| Quiescent DC Power Dissipated (No RF) | P_{DISS} | 7.8 | W |
| Junction Temperature | T_J | 170 | °C |
| Storage Temperature | T_{STG} | -55 to +150 | °C |

3. Operation beyond these limits may result in permanent damage to the part.

Recommended Operating Conditions⁴

| Characteristic | Symbol | Min | Typ | Max | Unit |
|-----------------------|---------------|------|------|--------|------|
| Drain Voltage | V_{DD} | 6.0 | 10.0 | 10.0 | V |
| Gate Voltage | V_{GG} | -2.6 | -2.0 | -1.2 | V |
| Input Power | P_{IN} | | 22.0 | 25.0 | dBm |
| Thermal Resistance | Θ_{JC} | | 13.1 | | °C/W |
| MMIC Base Temperature | T_B | | | Note 5 | °C |

4. Operation outside of these ranges may reduce product reliability.

5. MMIC Base Temperature = 170°C — $\Theta_{JC} * V_{DD} * I_{DQ}$

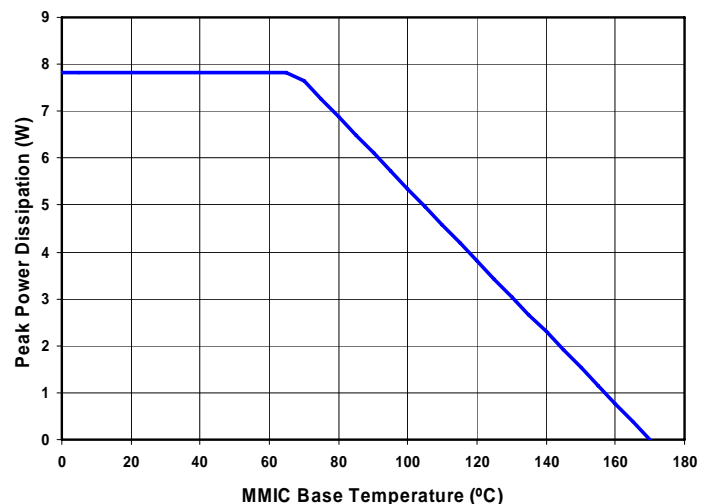


Operating Instructions

This device is static sensitive. Please handle with care. To operate the device, follow these steps.

1. Apply $V_{GG} = -2.7$ V, $V_{DD} = 0$ V.
2. Ramp V_{DD} to desired voltage, typically 10.0 V.
3. Adjust V_{GG} to set I_{DQ} , (approximately @ -2.0 V).
4. Set RF input.
5. Power down sequence in reverse. Turn V_{GG} off last.

Power Derating Curve, Quiescent (No RF)



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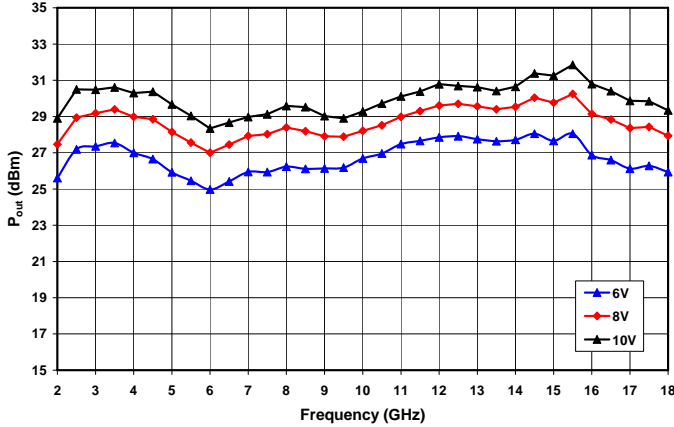


Figure 1. Output Power and Power Added Efficiency at $P_{in} = 22\text{dBm}$, and $I_{DSQ}=740\text{mA}$

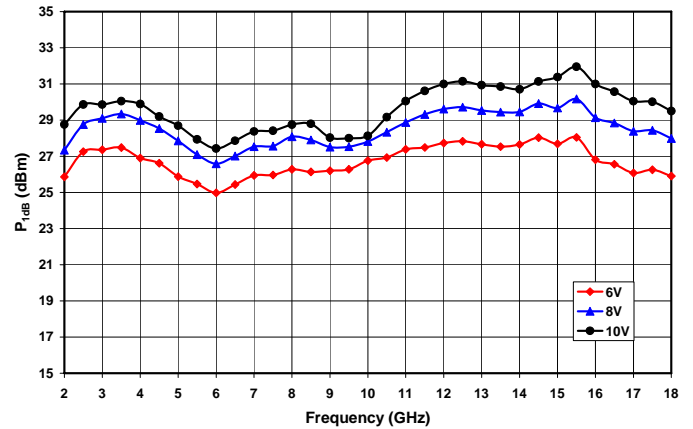


Figure 2. 1dB Compression Point and Drain Voltage at $I_{DSQ}=750\text{mA}$

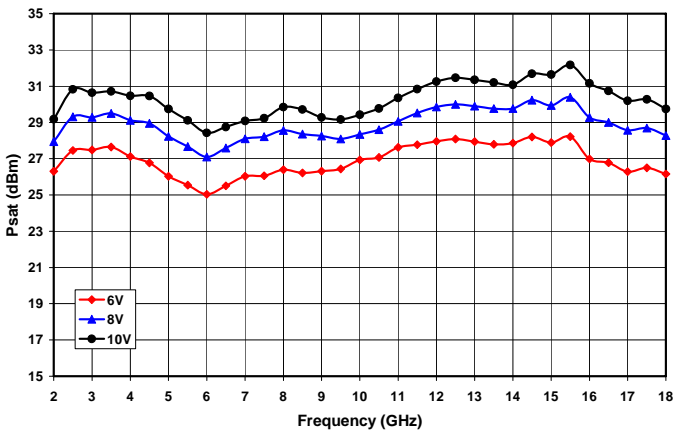


Figure 3. Saturated Output Power vs. Frequency and Drain Voltage

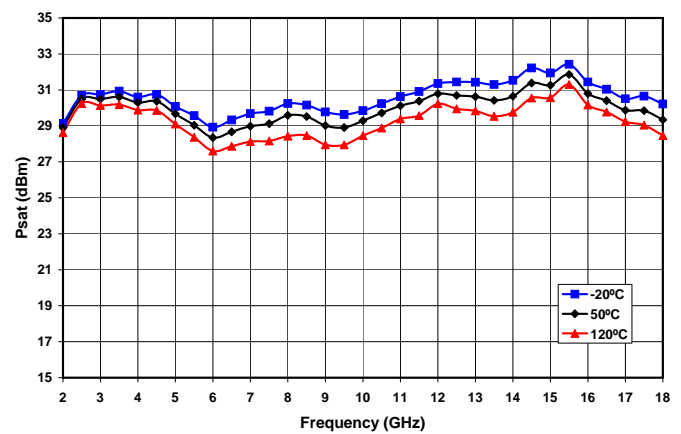


Figure 4. Saturated Output Power vs. Frequency and Temperature at $V_D=10\text{V}$ and $I_{DSQ}=750\text{mA}$.

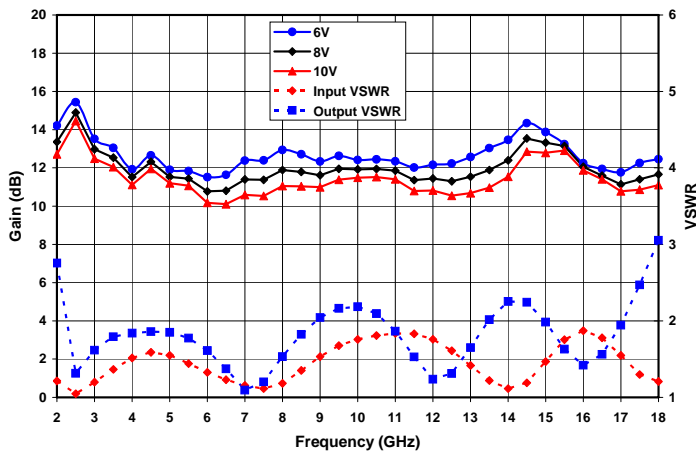


Figure 5. Small Signal Gain and Input and Output VSWR at $I_{DSQ}=750\text{mA}$.

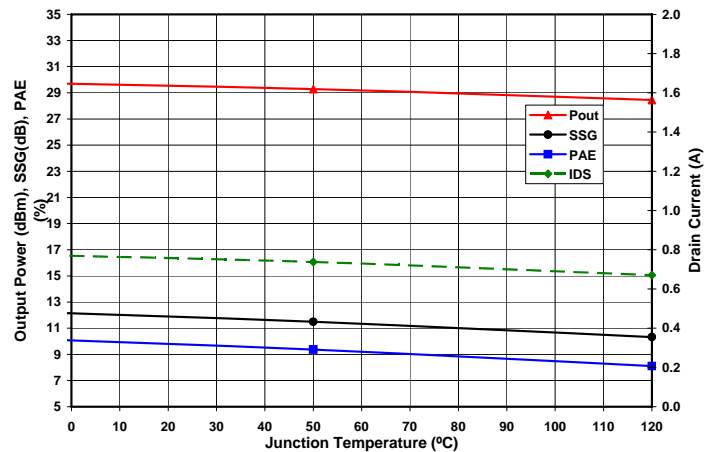


Figure 6. Output Power, Small Signal Gain, Power Added Efficiency, and Drain Current vs. Junction Temperature at 10V, 10GHz, and 750mA.

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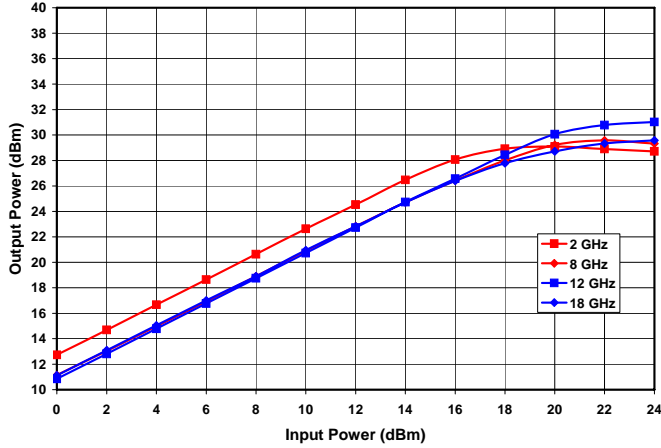


Figure 7. Output Power vs. Input Power and Frequency at 10V and 750mA

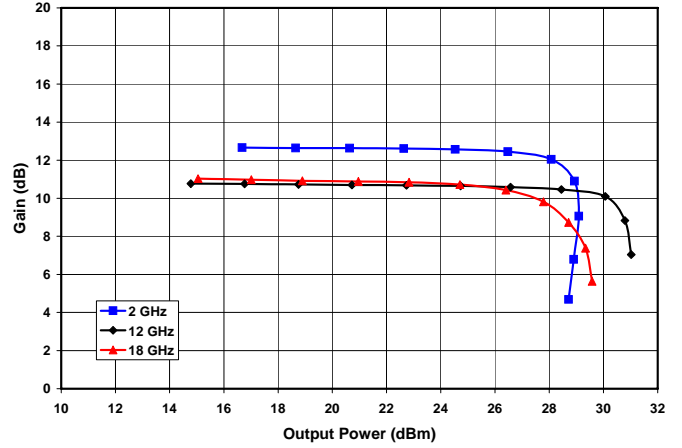


Figure 8. Gain vs. Output Power and Frequency at 10V and 750mA.

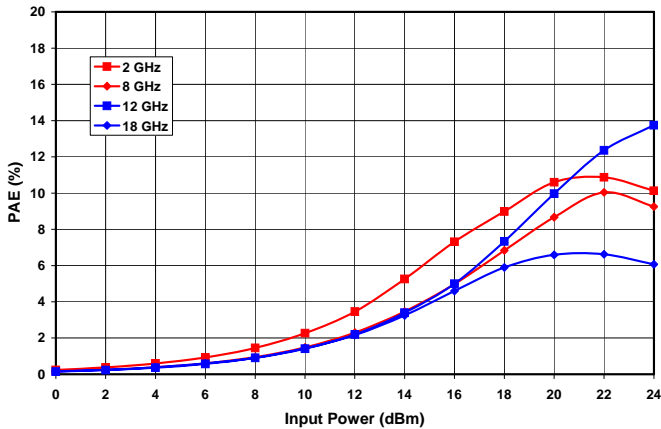


Figure 9. Power Added Efficiency vs. Input Power and Frequency at 10V and $I_{DC}=750mA$.

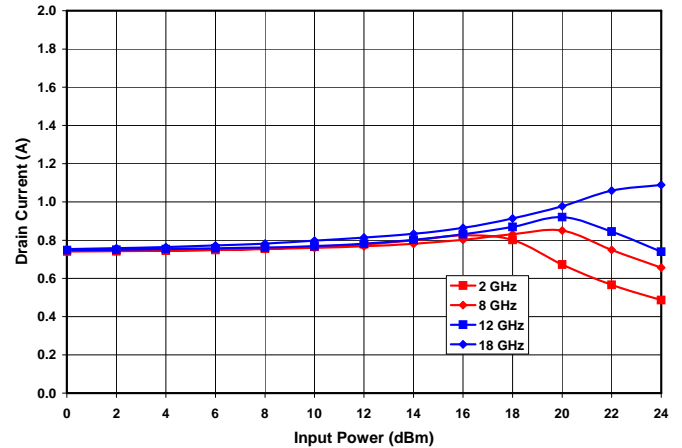


Figure 10. Drain Current vs. Input Power and Frequency at 10V and 750mA.

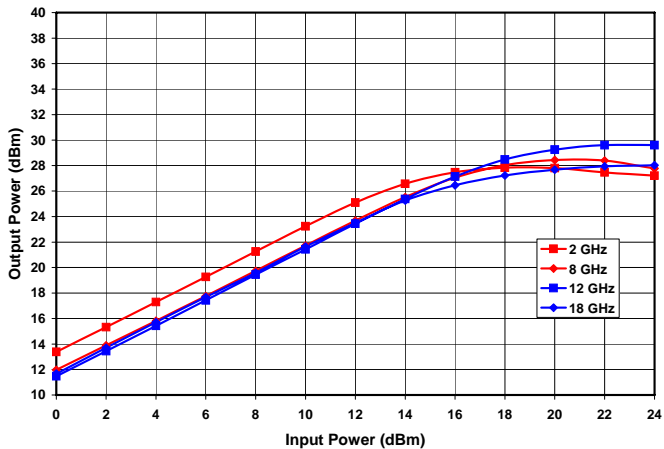


Figure 11. Output Power vs. Input Power and Frequency at 8V and 750mA.

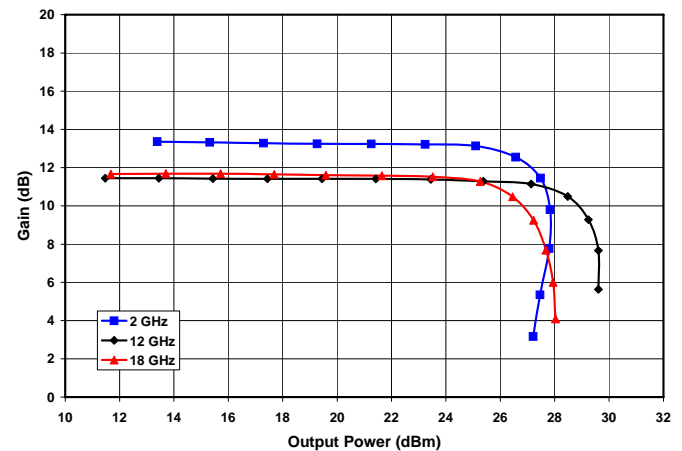


Figure 12. Gain vs. Output Power and Frequency at 8V and 750mA.

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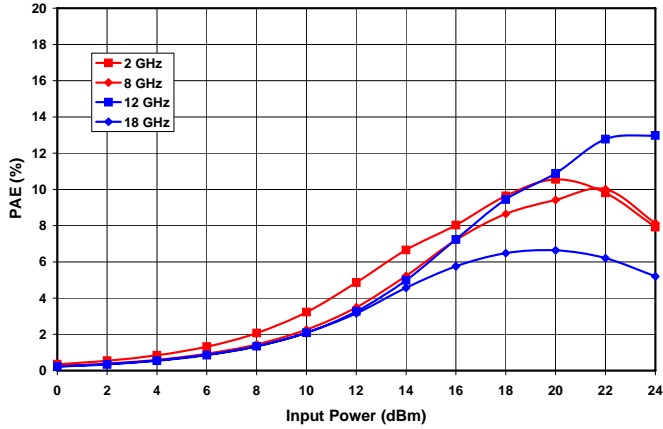


Figure 13. Power Added Efficiency vs. Input Power and Frequency at 8V and $I_{DSQ}=750mA$.

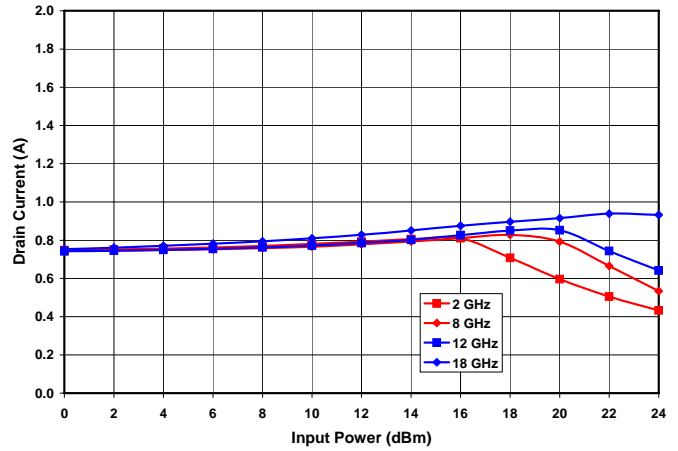
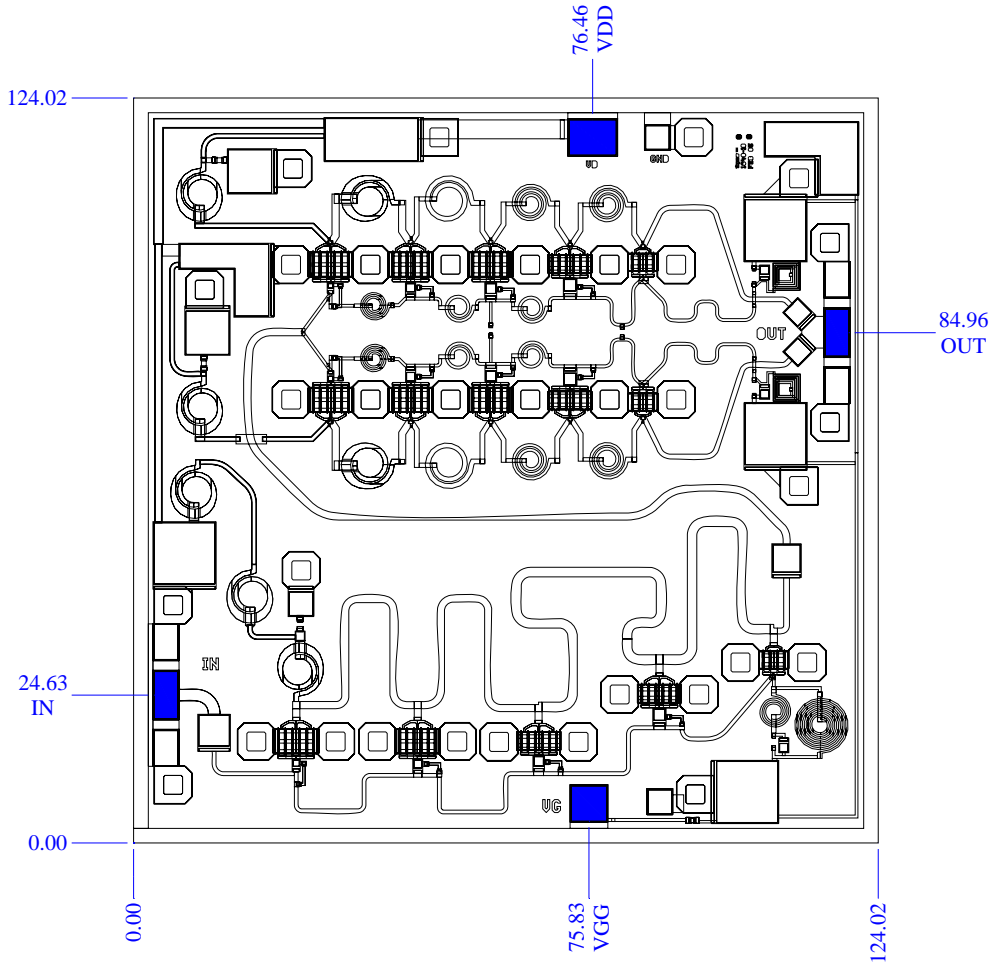


Figure 14. Drain Current vs. Input Power and Frequency at 8V and 750mA

Mechanical Information

Chip Size: 3.150 x 3.150 x 0.075 mm (124 x 124 x 3 mils)



Chip edge to bond pad dimensions are shown to the center of the bond pad (mils).

Figure 1. Die Layout

Bond Pad Dimensions

| Pad | Size (µm) | Size (mils) |
|-----------------------------|-----------|-------------|
| RF In and Out | 100 x 200 | 4 x 8 |
| DC Drain Supply Voltage VDD | 200 x 150 | 8 x 6 |
| DC Gate Supply Voltage VGG | 150 x 150 | 6 x 6 |

Assembly and Bonding Diagram

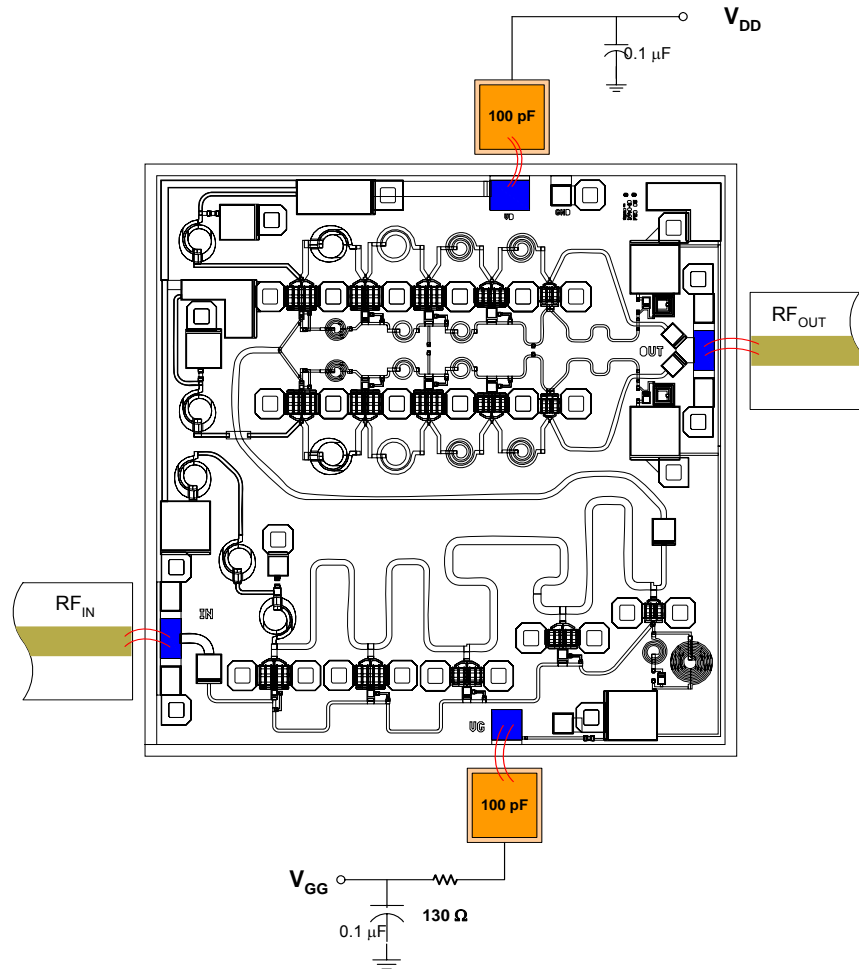


Figure 2. Recommended operational configuration. Wire bond as shown.

Assembly Instructions:

Die attach: Use AuSn (80/20) 1 mil. preform solder. Limit time @ 300 °C to less than 5 minutes.

Wirebonding: Bond @ 160 °C using standard ball or thermal compression wedge bond techniques. For DC pad connections, use either ball or wedge bonds. For best RF performance, use wedge bonds of shortest length, although ball bonds are also acceptable.

Biasing Note: Must apply negative bias to V_{GG} before applying positive bias to V_{DD} to prevent

